

Notice of References Cited

Application/Control No.

10/598,971

Applicant(s)/Patent Under

Reexamination

OSHIYAMA ET AL.

Examiner

Vu Nguyen

Art Unit

1796

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*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B US-2004/0058194 A1	03-2004	Stossel et al.	428/690
C	US-			
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K	US-			
L	US-			
M	US-			

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NON-PATENT DOCUMENTS

*	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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